

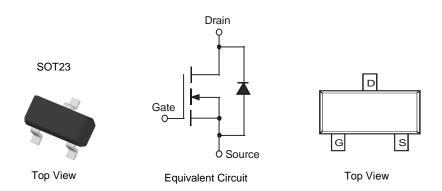
#### N-CHANNEL ENHANCEMENT MODE MOSFET

#### **Features**

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The BSS138Q is suitable for automotive applications requiring specific change control; this part is AEC-Q101 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.
- https://www.diodes.com/quality/product-definitions/

## **Mechanical Data**

- Case: SOT23
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish Annealed over Alloy 42 Leadframe (Lead Free Plating). Solderable per MIL-STD-202, Method 208 @
- Terminal Connections: See Diagram
- Weight: 0.008 grams (Approximate)



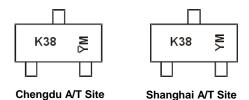
### Ordering Information (Note 4)

Part Number	Qualification	Case	Packaging
BSS138-7-F	Commercial	SOT23	3000/Tape & Reel
BSS138-13-F	Commercial	SOT23	10000/Tape & Reel
BSS138Q-7-F	Automotive	SOT23	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## **Marking Information**



K38 = Product Type Marking Code

YM = Date Code Marking for SAT (Shanghai Assembly/ Test Site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test Site)

Y or  $\overline{Y}$  = Year (ex: G = 2019)

M = Month (ex: 9 = September)

Date Code Key

Date Code Ney															
Year	1998	1999	2000		2002	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025
Code	J	K	L		N	D	E	F	G	Н	I	J	K	L	М
Month	Jan	Fe	b	Mar	Apr	May	Ju	ın	Jul	Aug	Sep	Oc	t I	Nov	Dec
Code	1	2		3	4	5	6	6	7	8	9	0		N	D

1 of 5 **BSS138** October 2019 © Diodes Incorporated Document number: DS30144 Rev. 22 - 2



# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	50	V	
Drain-Gate Voltage $R_{GS} \le 20 K\Omega$	$V_{DGR}$	50	V	
Gate-Source Voltage Continuous		V <sub>GSS</sub>	±20	V
Gate-Source Voltage Non Repetitive, Pulse Width<50μs			±40	V
Drain Current Continuous		I <sub>D</sub>	200	mA
Pulsed Drain Current (10µs Pulse Duty Cycle = 1%)	I <sub>DM</sub>	1	A	

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

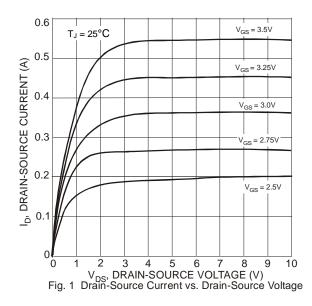
Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	$P_{D}$	300	mW
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ hetaJA}$	417	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

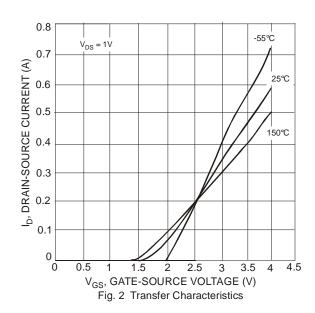
### Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)	_						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	50	75		V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		_	0.5	μΑ	$V_{DS} = 50V$ , $V_{GS} = 0V$	
Gate-Body Leakage	I <sub>GSS</sub>		_	±100	nΑ	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.5	1.2	1.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>		1.4	3.5	Ω	$V_{GS} = 10V, I_D = 0.22A$	
Forward Transconductance	<b>g</b> FS	100	_	_	mS	$V_{DS} = 25V$ , $I_D = 0.2A$ , $f = 1.0KHz$	
DYNAMIC CHARACTERISTICS							
Input Capacitance	Ciss			50	pF		
Output Capacitance	Coss		_	25	pF	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz$	
Reverse Transfer Capacitance	C <sub>rss</sub>		_	8.0	pF	1	
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t <sub>D(ON)</sub>			20	ns	V 20V I 0.24 B 500	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	_	20	ns	$V_{DD} = 30V, I_D = 0.2A, R_{GEN} = 50\Omega$	

Notes:

<sup>6.</sup> Short duration pulse test used to minimize self-heating effect.





<sup>5.</sup> Device mounted on FR-4 PCB 1.0 x 0.75 x 0.062 inch pad layout as shown on Diodes Incorporated's suggested pad layout, which can be found on our website at http://www.diodes.com/package-outlines.html.



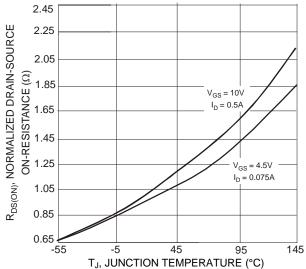


Fig. 3 Drain-Source On-Resistance vs. Junction Temperature

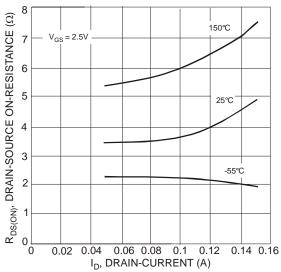


Fig. 5 Drain-Source On-Resistance vs. Drain-Current

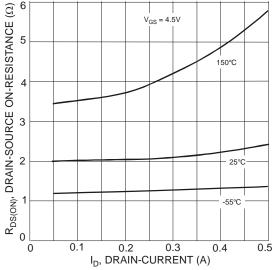
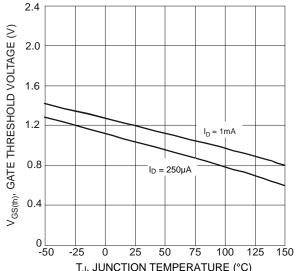


Fig. 7 Drain-Source On-Resistance vs. Drain-Current



T<sub>J</sub>, JUNCTION TEMPERATURE (°C) Fig. 4 Gate Threshold Variation vs. Junction Temperature

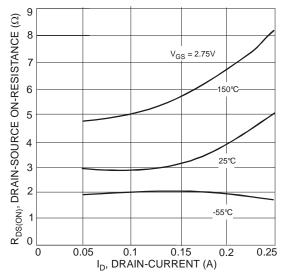


Fig. 6 Drain-Source On-Resistance vs. Drain-Current

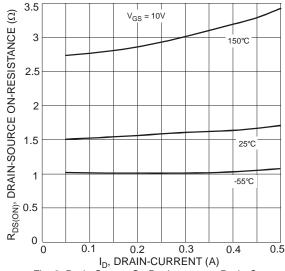
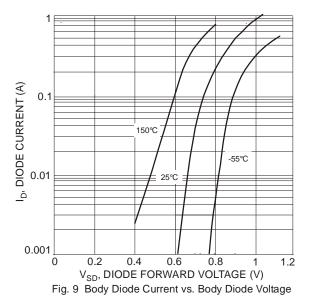
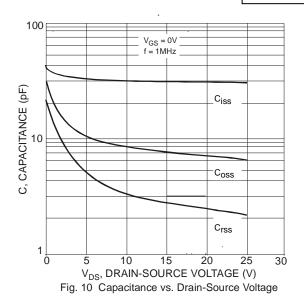


Fig. 8 Drain-Source On Resistance vs. Drain-Current

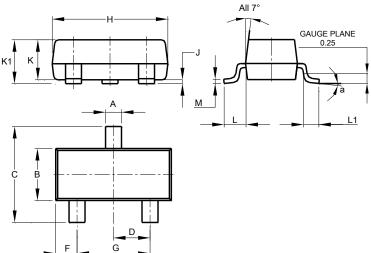






## **Package Outline Dimensions**

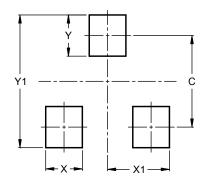
Please see http://www.diodes.com/package-outlines.html for the latest version.



SOT23								
Dim	Min	Max	Тур					
Α	0.37	0.51	0.40					
В	1.20	1.40	1.30					
С	2.30	2.50	2.40					
D	0.89	1.03	0.915					
F	0.45	0.60	0.535					
G	1.78	2.05	1.83					
Н	2.80	3.00	2.90					
J	0.013	0.10	0.05					
K	0.890	1.00	0.975					
K1	0.903	1.10	1.025					
L	0.45	0.61	0.55					
L1	0.25	0.55	0.40					
M	0.085	0.150	0.110					
а	0°	8°						
All	All Dimensions in mm							

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	2.0
Х	0.8
X1	1.35
Y	0.9
Y1	2.9



#### IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2019, Diodes Incorporated

www.diodes.com

5 of 5 **BSS138** October 2019 © Diodes Incorporated Document number: DS30144 Rev. 22 - 2

单击下面可查看定价,库存,交付和生命周期等信息

>>Diodes Incorporated(达尔科技)